

炭素のケミカルスパッタリングIV(堆積炭素)

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Contents

1. Introduction: Background, 2007-2009 Reports & Aim
2. 堆積炭素とは; Redeposit C, CFC (Carbon nanotube?), Aim & Literature survey
3. Temp., Energy & Fluence dependences, Dopant effect
4. Summary, Graphite vs W
5. Dynamic retention

Background : Graphite for fusion-plasma walls

H(D) on pure-graphite [2007 Report]

- Chemical sputtering: Reaction of H(D) with C, formation and escape of hydrocarbons.
 - * For H energy > 0.3 keV, yield takes maximum at Ts~800K, CH₄ dominant, larger by an order of magnitude than physical sputtering
 - e.g. ~0.01 /ion for 1 keV H , Matsunami et al. ADNDT 31(1984)1., Yamamura et al. ADNDT62(1996)149.
 - For low energy, Ts~600K, contribution other than CH₄ becomes larger.
- * c.f. Enhanced sublimation, >1200K, Philips et al. JNM 155-157(1988)319.
- *NB. Reflection, ~0.1 at 1 keV H on C, Tabata et al. NIM B9(1985)113
- *Related phenomena: Reemission, Retention

H(D) on doped-graphite [2008 Report]

Dopant (10 elements)

B, Be, Si, Ti, W, V, Fe, Cr, Li, Zr

Suppression of chemical sputtering.

~10 % doping is effective.

O & N impact on graphite [2009 Report]

Chemical sputtering

O impact, CO (main component), Yield ~1

Energy Distribution of CO at RT, MB + Collision cascade

N impact, Yield ~1

(C impact, chemical sputtering was not observed.)

Graphite vs Diamond

DGM1997a 2k7.2.15

C.D.Donnelly, R.W.McCullough, J. Geddes,
Diamond & Related Mat. 6(1997)787.

$Y(\text{diamond}) \ll Y(\text{graphite})$,
 > 3 order of magnitude

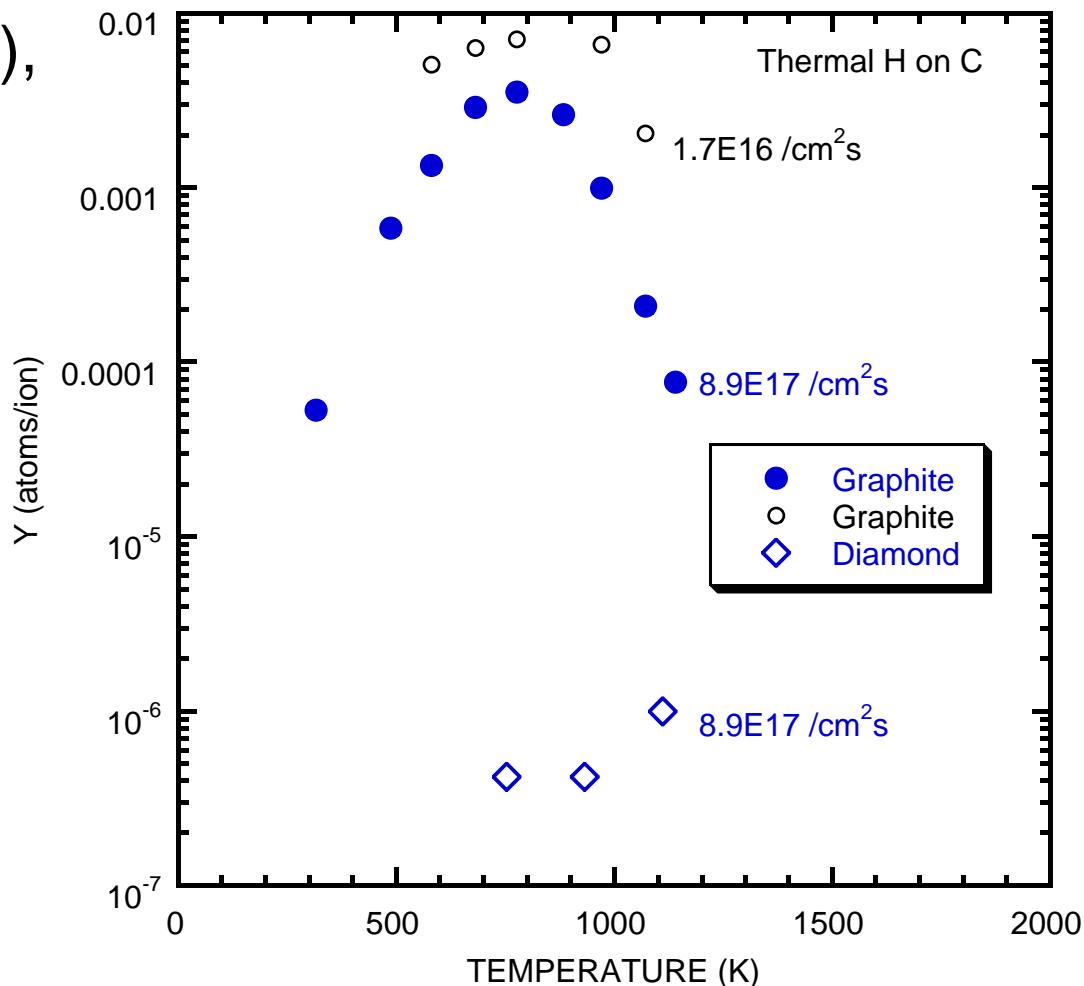
Desired are the data for
 energetic H impact.

Thermal H on a:C(H), Horn et al.
 Chem. Phys. Lett. 231(1994)193.

*CH₃ emission max. at 600 K

$Y \sim 0.01$

Inconsistent



C. M. Donnelly, R.W. McCullough, J. Geddes,
 Diamond Rel. Mat. 6(1997)787.

堆積炭素のケミカルスパッタリング [2010 Report]⁵

*堆積炭素とは? Re-deposited C

Wide variation of
SP2+SP3, Structure, Density, Impurities

*Lab. Exp.

Carbon fiber-reinforced carbon composite (CFC)

*Similarity to Carbon nanotube?

Aim

* Data compilation & understanding of chemical sputtering of graphite: CFC

* CFC: ~14 papers [2010 Report]

Temperature Dependence(1)

0.6 keV H₂ on DC & Graphite

*Chemical sputtering Yields
DC < Graphite

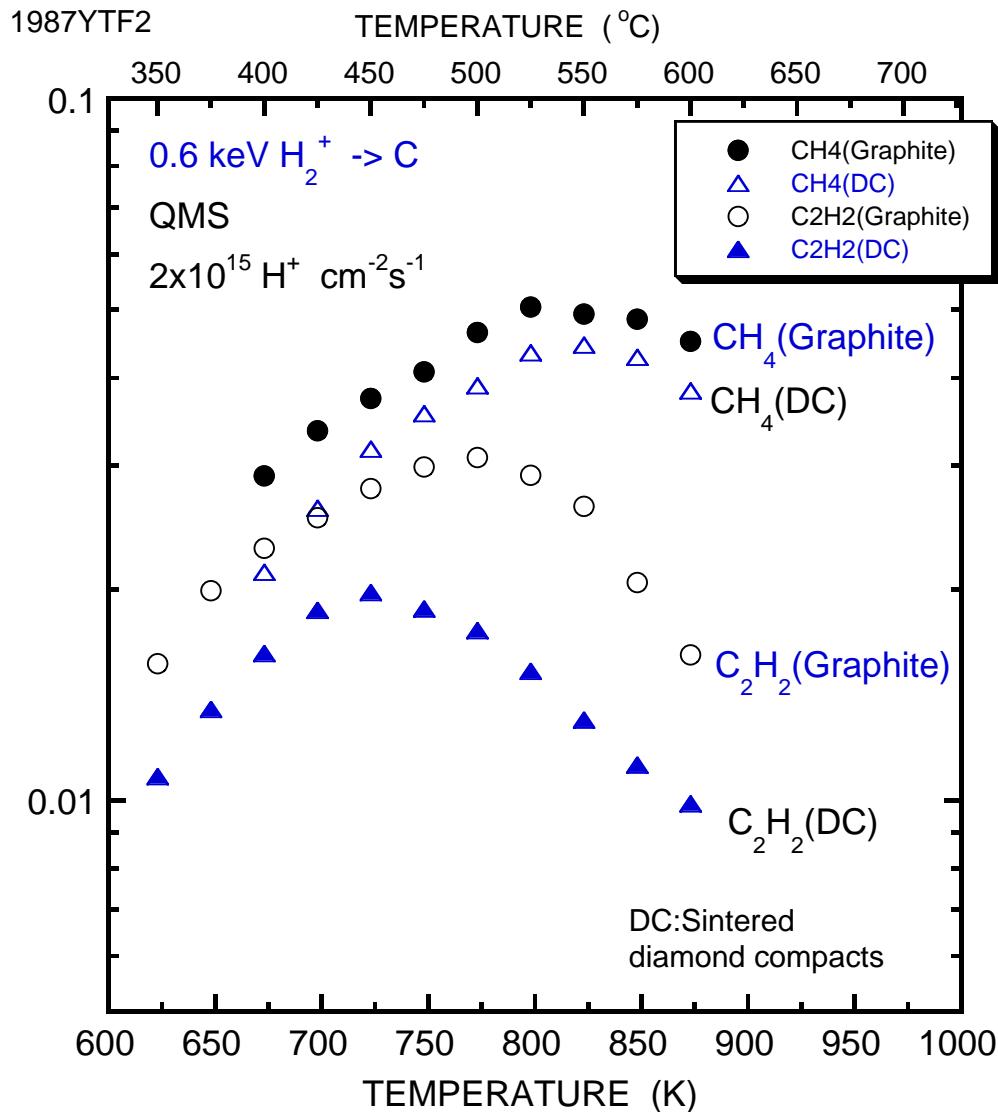
*DC, density~2.2 gcm⁻³
diamond 2.26 gcm⁻³

*SP3 is remained after ion impact (Raman spectroscopy)

Ion Impact Graphitization ?

SP2/SP3 before and after ion impact?

Phys. Sputtering ~0.01 (0.3 keV H)



Temperature Dependence(2)

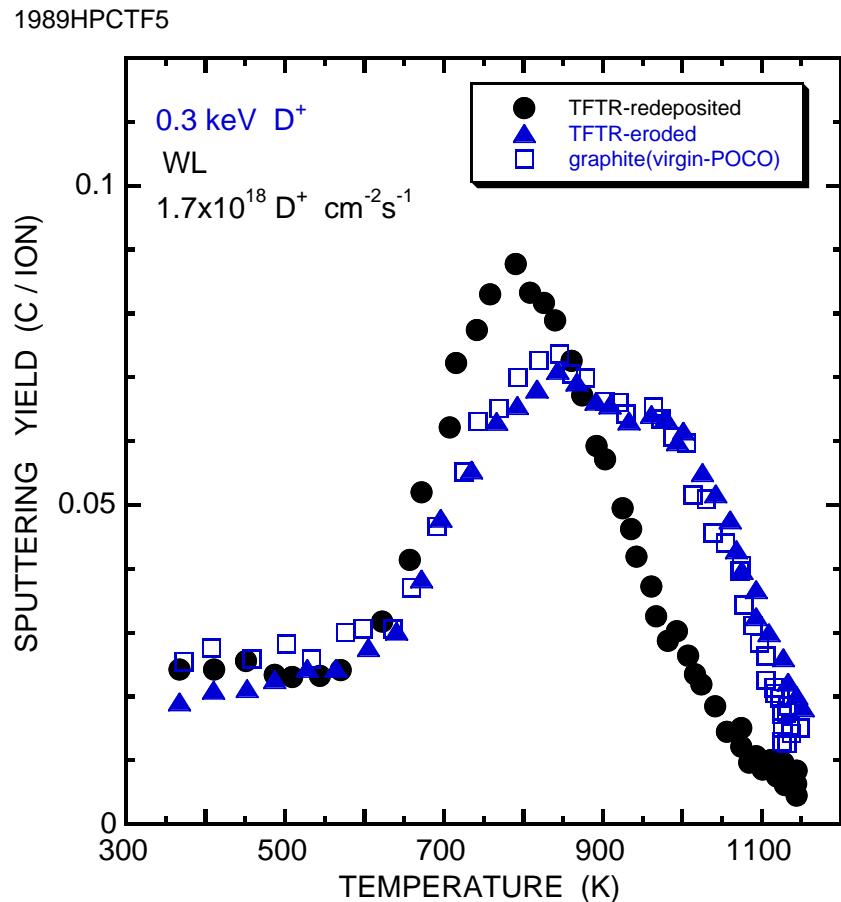
TFTR-redeposit C

*Chem. Sp. Yield is larger by
~20 % than Graphite

* Impurity (O, Si, S, Cr, Fe, Ni)
inclusion

Phys. Sp. Y. ~ 0.01

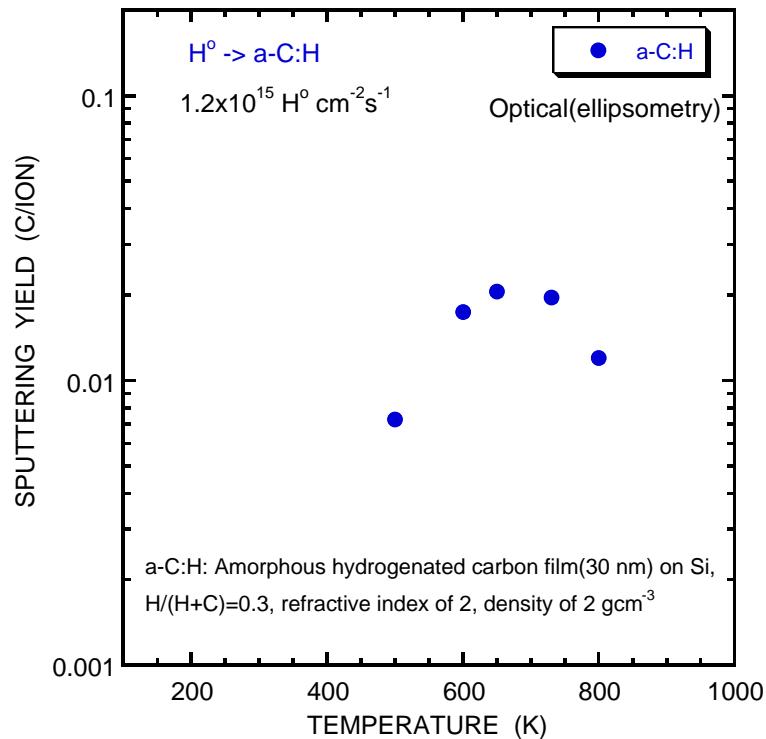
Normal incidence.



Y. Hirooka, A. Pospieszczyk, R. W. Conn, B. Mills, R. E. Nygren, Y. Ra,
J. Vac. Sci. Technol. A7(1989)1070.

Temperature Dependence(3)

2008SHSTF2



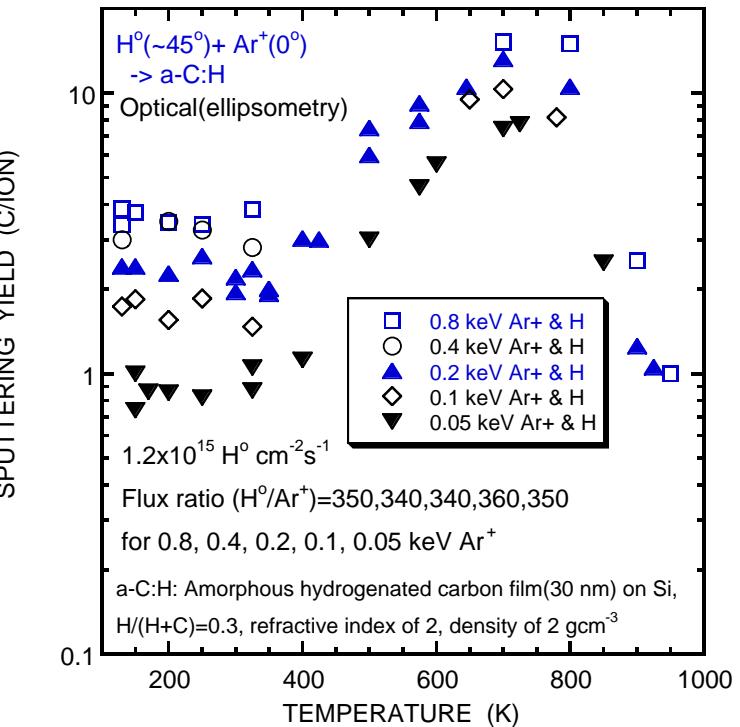
M. Schluter, C. Hopf, T. S.-Selinger, W. Jacob,
J. Nucl. Mater. 376(2008)33.

Cf. Diamond

Y(a-C:H) >> Y (Diamond)

$\sim 10^{-5}$

2008SHSTF3



M. Schluter, C. Hopf, T. S.-Selinger, W. Jacob,
J. Nucl. Mater. 376(2008)33.

Ar+ & H impact

Synergistic effect

Y(phys. sp.) ~5 (0.8 keV Ar)

Energy Dependence(1a)

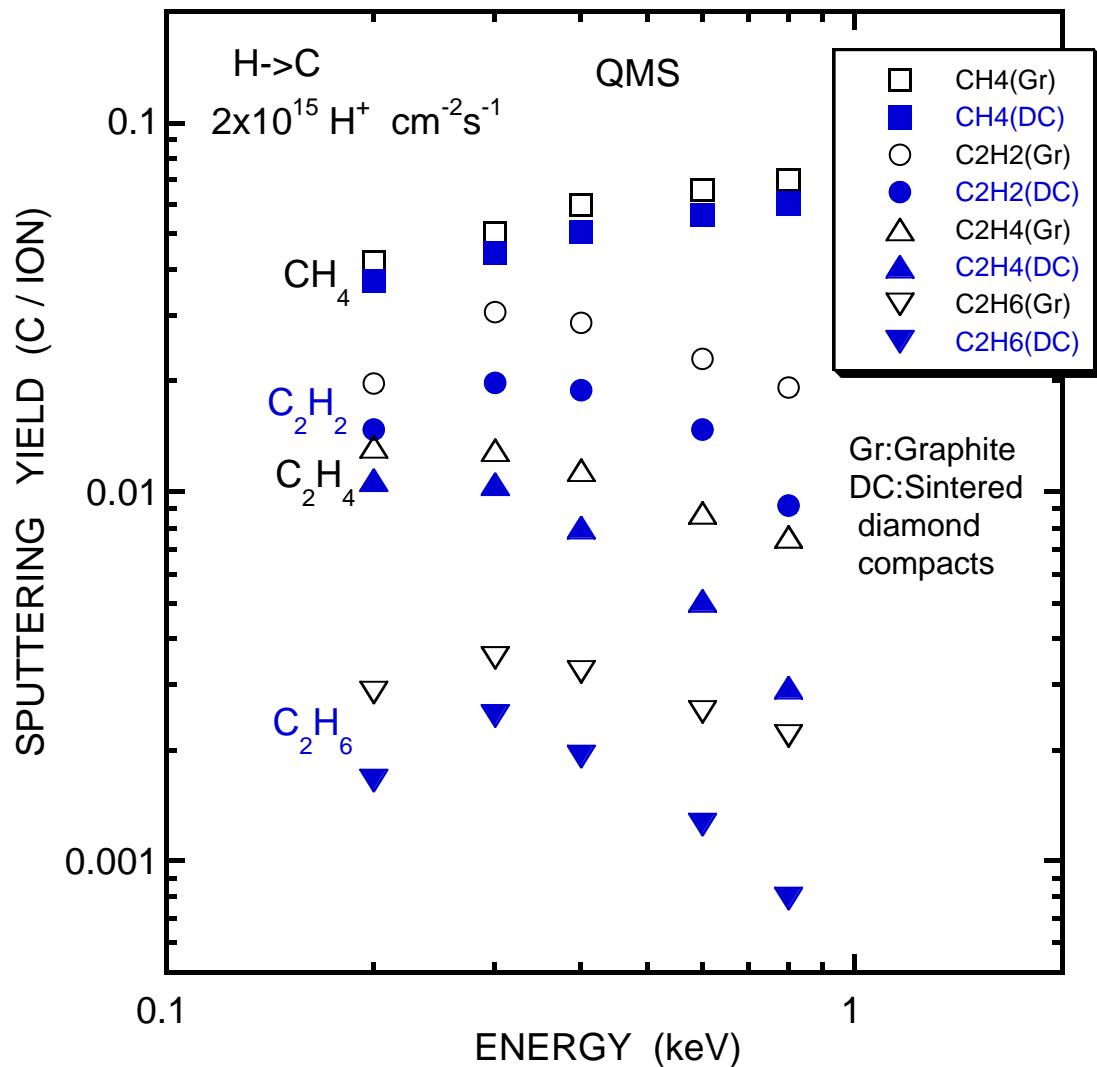
1987YEF3

*Chem. Sp.

*CH Component

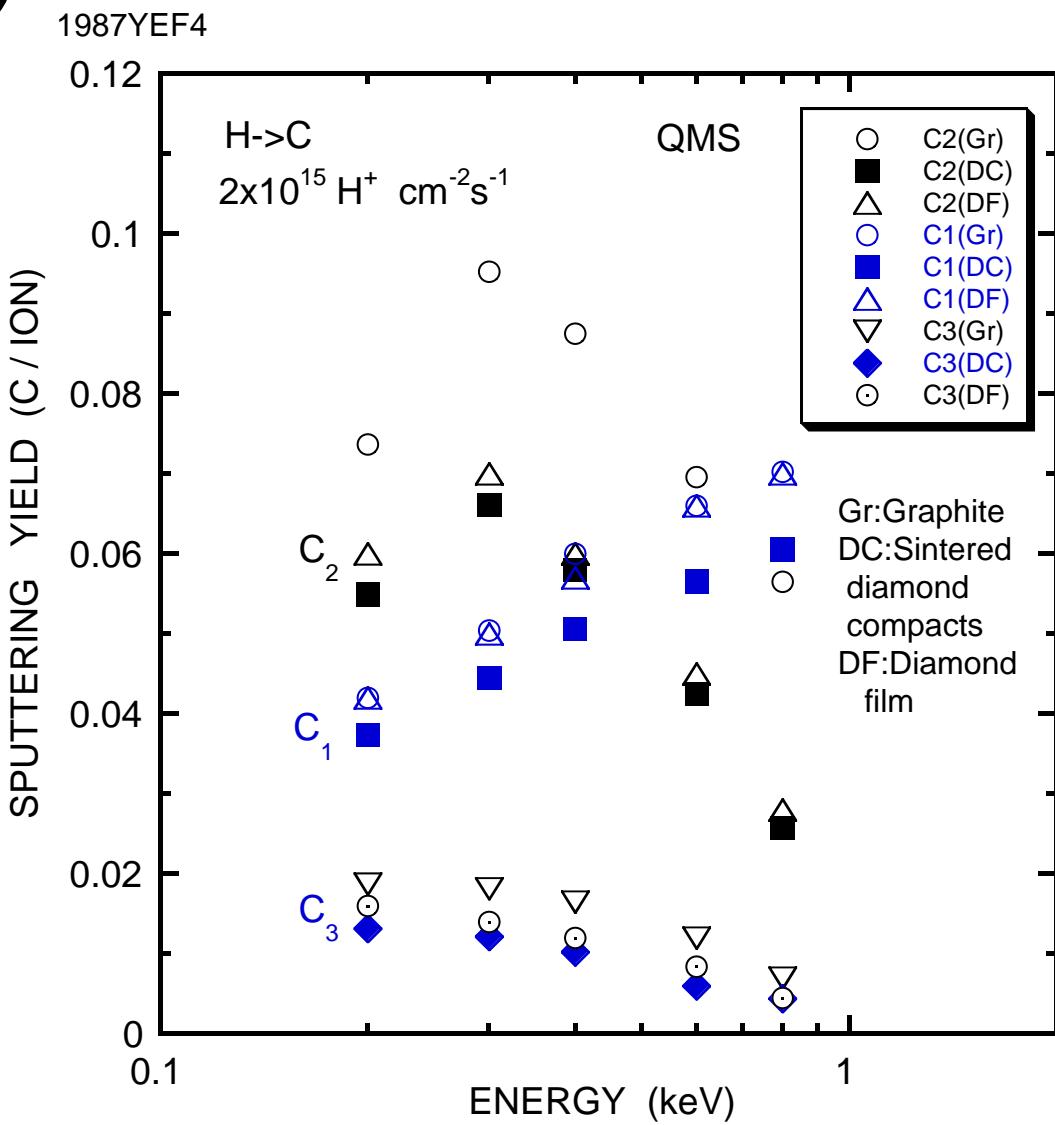
1. DC ~ Graphite

2. $C_1(CH_4) > C_2(C_2H_2 \text{ etc})$



Energy Dependence(1b)

- *Chem. Sp. \geq Phys. Sp.
- *E < 1 keV
- 1. C₂(C₂H₂ etc),
DC & DF < Graphite
- 2. C₁(CH₄), C₃(C₃H₈),
DC~DF~Graphite

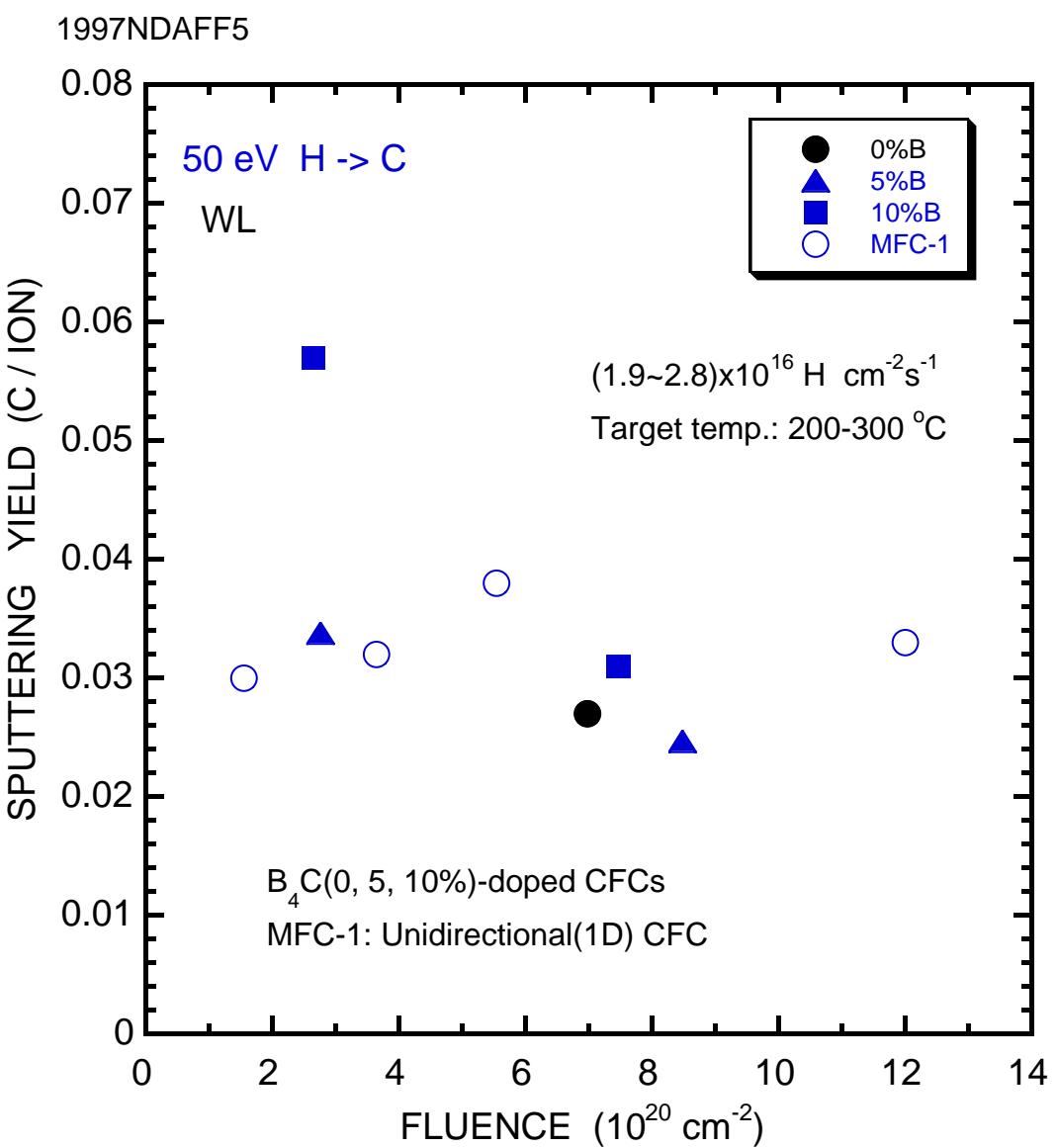


Fluence Dependence

*Fluence Dep. ~ Weak

*B-doping: Little effect

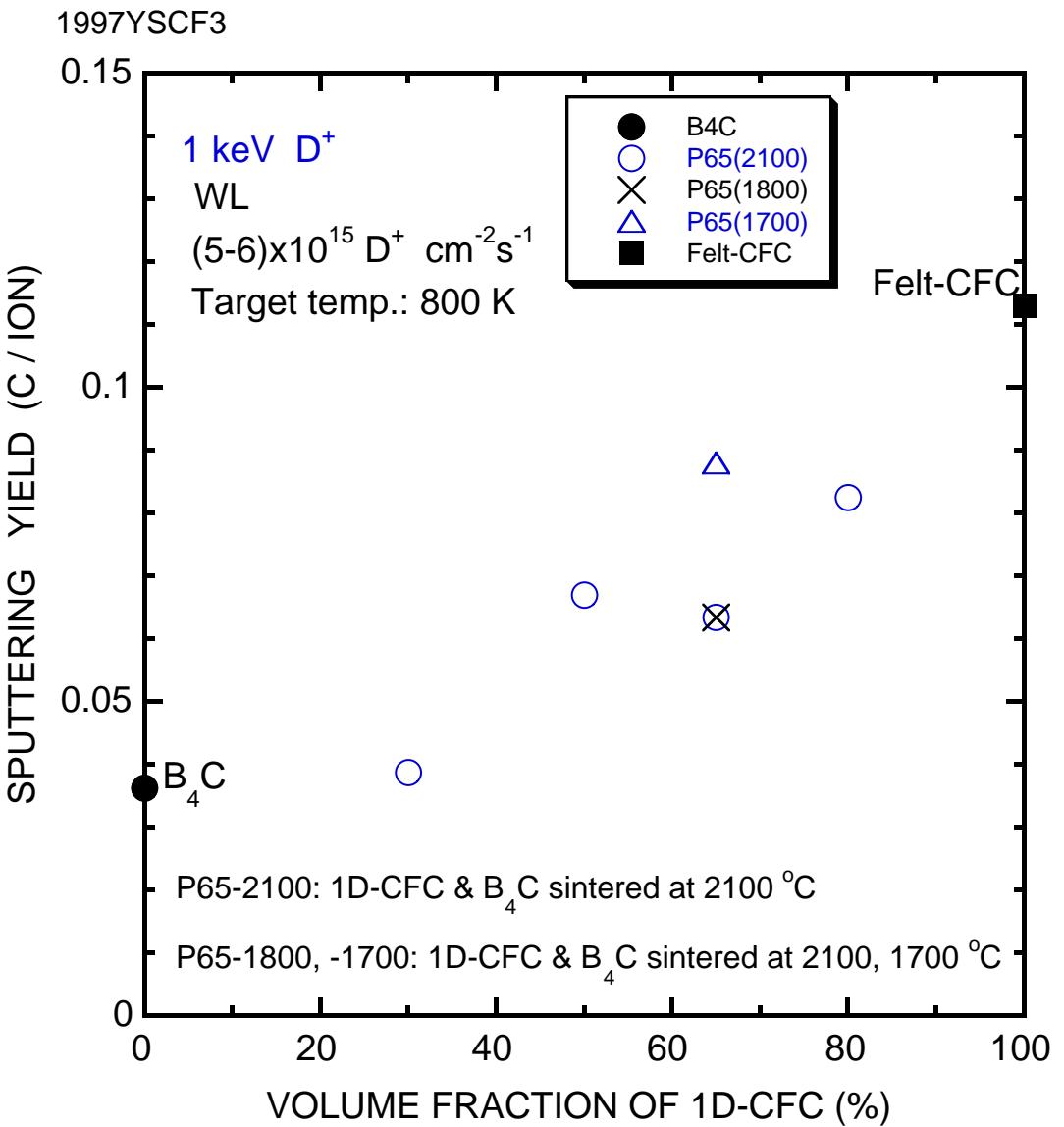
*Data at higher temp.
is desired.



Dopant Effect

B-doping

Suppression of
Chem. Sp.



- Survey of chemical sputtering data: CFC
- Appreciable chemical sputtering, Comparable with Graphite
Ion induced graphitization?, Comparison with Diamond?

Future problems

- Graphite vs W
Comparison; Mechanical, Thermal, etc. Properties
Gr.; Suppression of Chemical sputtering
H Retention (static, dynamic)
- A simple analytical formula?
- Data compilation, publication?

Model: pure graphite

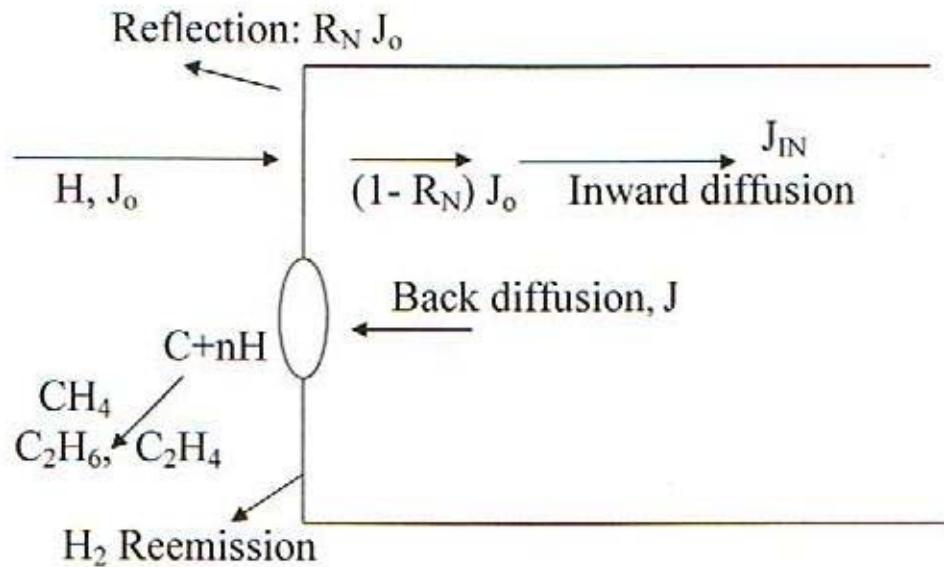
14

S.K.Erents, C.M.Braganza, G.M.McCracken, J. Nucl. Mat.63(1976)399.

H, O, N impact

Hydrocarbon

CO, CO₂, C₂N₂



$$Y_{\text{chem}} = n_H * \text{cnst} * \exp(-Q_1/RT),$$

$$n_H: \text{H conc. at surfce, } dn_H/dt = J - J_0 \sigma n_H - n_H / (\tau_0 \exp(Q_2/RT))$$

ion-induced desorption thermal desorption

$Q_1: 159 \text{ kJ/mol}$, activation energy (heat of CH₄ formation?)

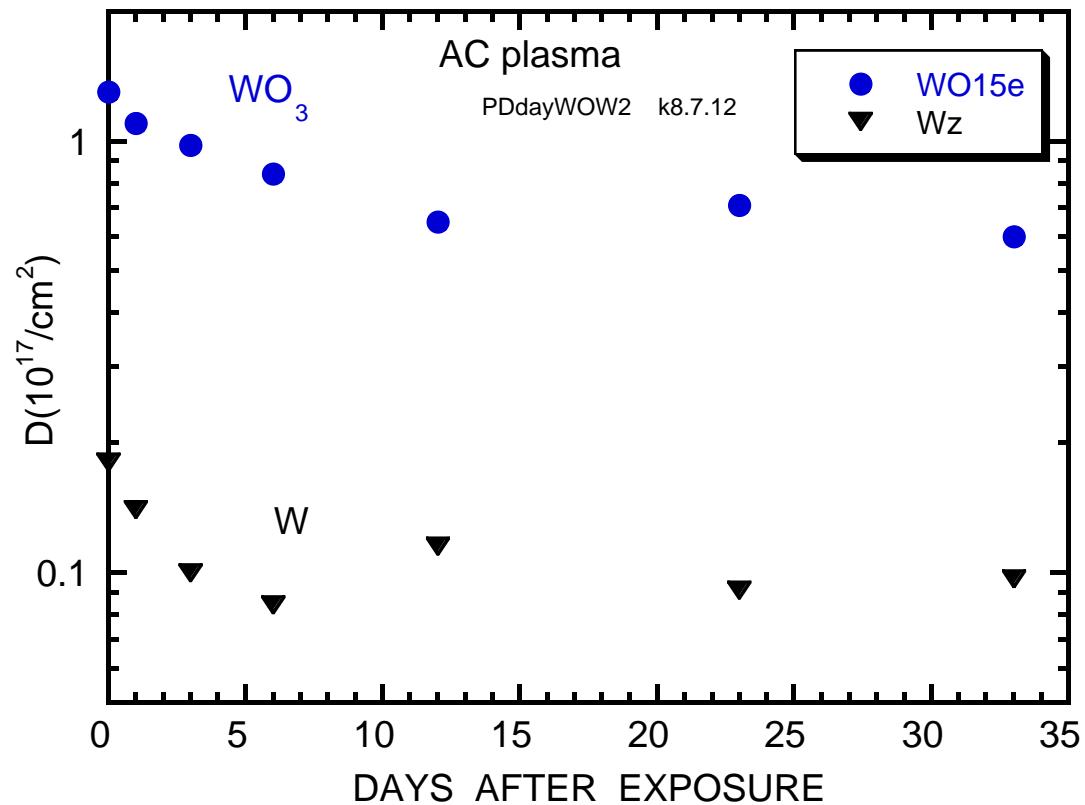
$Q_2: 228 \text{ kJ/mol}$

R_N : Reflection coefficient

Deuterium Retention in WO_3 and W

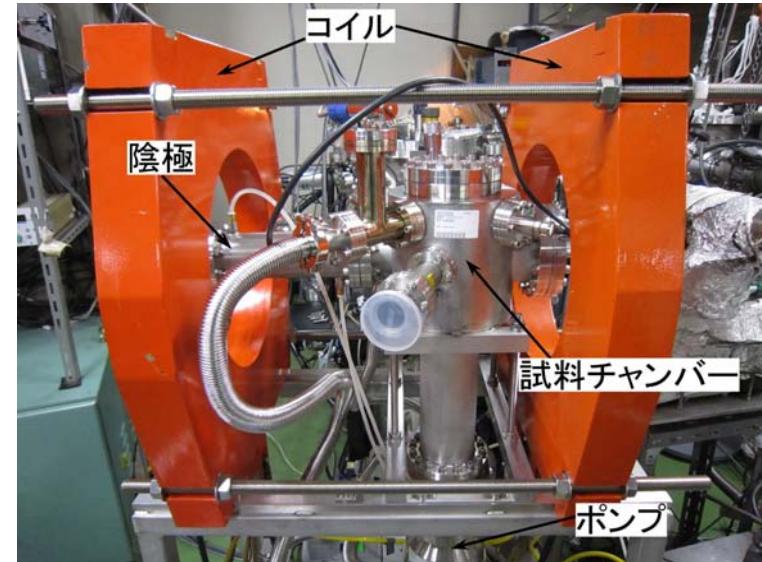
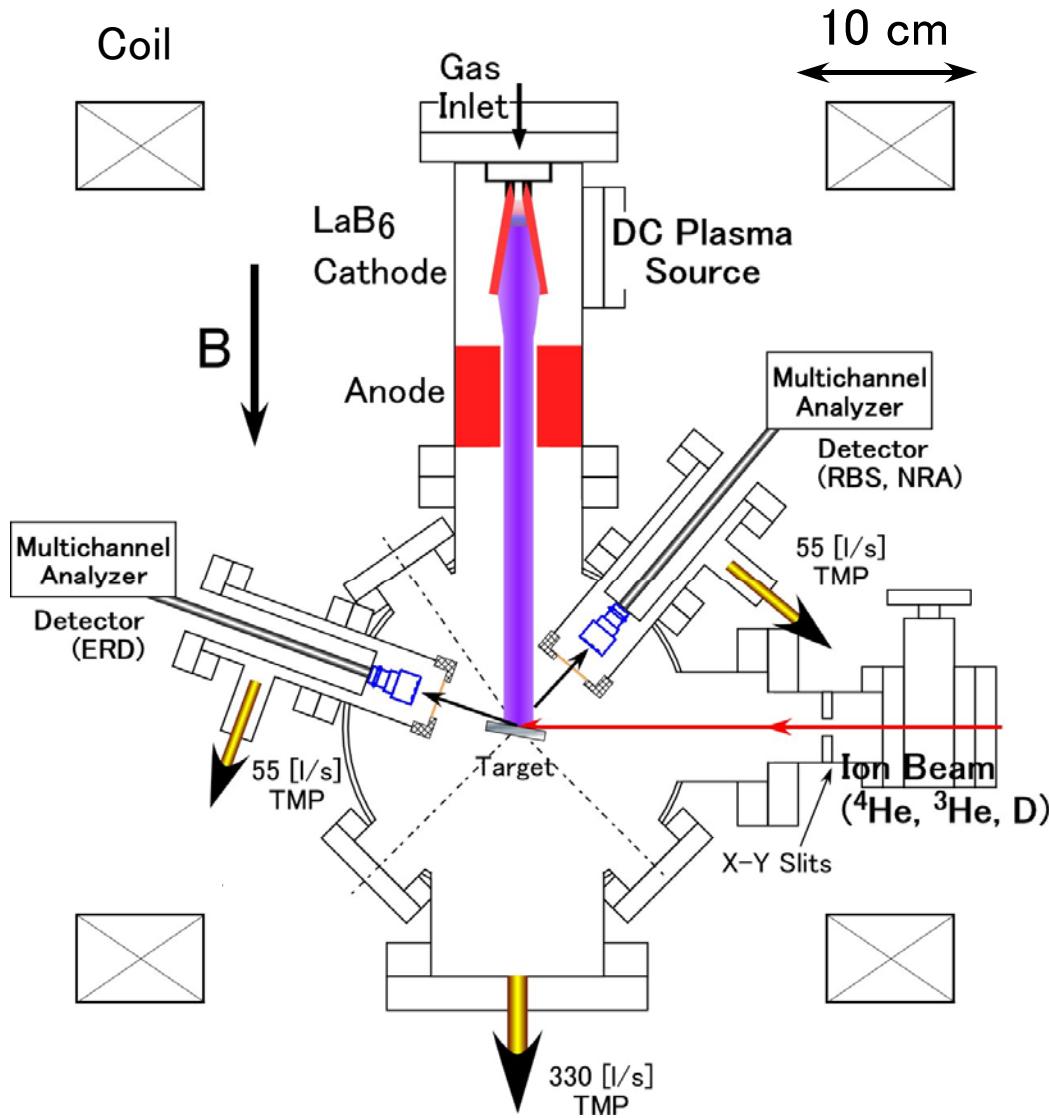
When $\text{WO}_3(\text{D})$ & $\text{W}(\text{D})$
are kept in air at RT,
Deuterium Escape
was observed.

***Dynamic Retention**

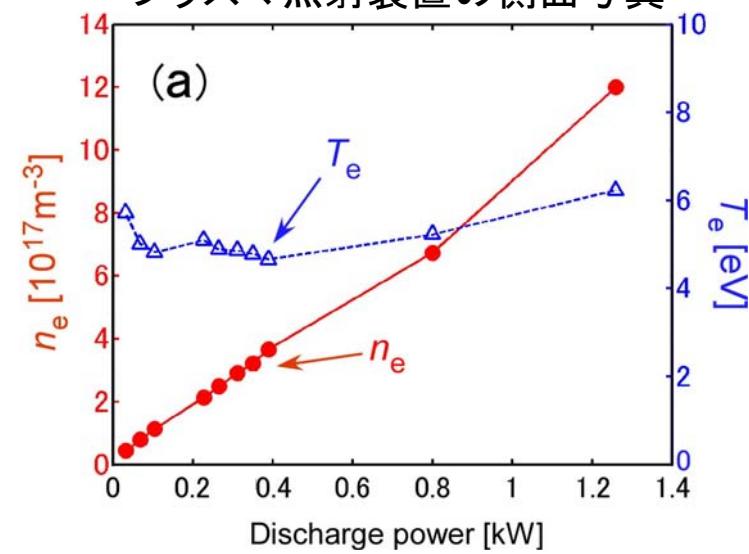


1.5 kV AC (60 Hz), Maximum D energy= 1.06 keV,
Efficiency ~4%, Reflection ~50%(D on W),
***Dynamic Retention**

開発した小型高熱流プラズマ照射装置



プラズマ照射装置の側面写真



プラズマ特性図(投入電力依存性)